

Search Notes

Application/Control No.

10/069,004

Examiner

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Applicant(s)/Patent under
Reexamination

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Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
370	349	10/20/2005	BQN
370	470	10/20/2005	
370	471	10/20/2005	
370	466	10/20/2005	
370	467	10/20/2005	
370	468	10/20/2005	
370	350	10/20/2005	
370	329	10/20/2005	
709	249	10/20/2005	

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (US-GPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM-TDB), see more on search history.	10/20/2005	BQN
Consulted with Wellington Chin	10/20/2005	BQN